

**Notice of References Cited**

Application/Control No.

10/587,729

Applicant(s)/Patent Under

Reexamination

VELDHUIZEN ET AL.

Examiner

Christopher R. Lea

Art Unit

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0013708	01-2004	Goulson et al.	424/439
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	WO 0033669 A1	06-2000	World Intellect	DAHLSTEN C-J et al.	
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	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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